

Product Description

The PE94302 is a high linearity, 6-bit UltraCMOS™ RF Digital Step Attenuator (DSA) specifically optimized for rad-hard space applications. This 50-ohm RF DSA covers a 31.5 dB attenuation range in 0.5 dB steps. It provides both parallel and serial CMOS control interface. The PE 94302 maintains high attenuation accuracy over frequency and temperature and exhibits very low insertion loss and power consumption.

The PE94302 is manufactured on Peregrine's UltraCMOS™ process, a patented variation of silicon-on-insulator (SOI) technology on a sapphire substrate, offering the performance of GaAs with the economy and integration of conventional CMOS.

**50 Ω RF Digital Step Attenuator
For Rad-Hard Space Applications
6-bit, 31.5 dB, DC – 4.0 GHz**

Features

- Attenuation: 0.5 dB steps to 31.5 dB
- Flexible parallel and serial programming interfaces
- 100 Krads (Si) Total Dose
- Positive CMOS control logic
- High attenuation accuracy and linearity over temperature and frequency
- Very low power consumption
- 50 Ω impedance

Figure 1. Functional Schematic Diagram

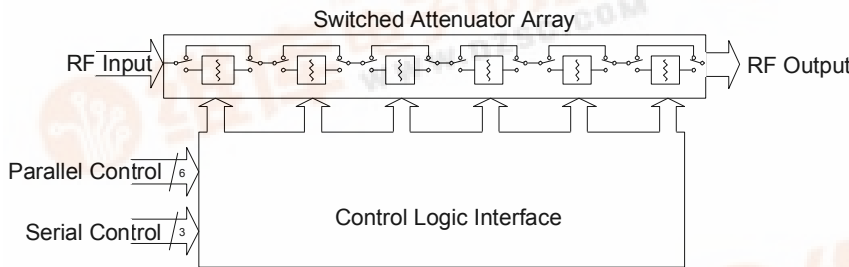


Figure 2. Package Type
28-lead CQFP



Table 1. Electrical Specifications @ +25°C, V_{DD} = 3.0 V

Parameter	Test Conditions	Frequency	Typical	Max	Units
Operation Frequency ³		DC-4000			MHz
Insertion Loss		DC - 2.2 GHz	1.5		dB
Attenuation Accuracy	Any Bit or Bit Combination 0.5 dB - 23.5 dB Attenuation 24 dB - 31.5 dB Attenuation	DC ≤ 1.0 GHz 1.0 GHz ≤ 2.2 GHz 1.0 GHz ≤ 2.2 GHz	+/- (0.25 + 3% of attenuation setting) +/- (0.25 + 5% of attenuation setting) +/- (11% of attenuation setting)		dB
1 dB Compression ^{1,2}		1 MHz - 2.2 GHz	34		dBm
Input IP3 ¹	Two-tone inputs	1 MHz - 2.2 GHz	52		dBm
Return Loss		DC - 2.2 GHz	20		dB
RF Input Power (50 Ω)				12	dBm
Switching Speed	50% of control voltage to 90% of final attenuation level		1		μs

Notes: 1. Device Linearity will begin to degrade below 1 MHz
 2. Maximum Operating Power = +12 dBm
 3. Specs are guaranteed to 2.2 GHz, Characterized to 4.0 GHz



Figure 3. Pin Configuration (Top View)

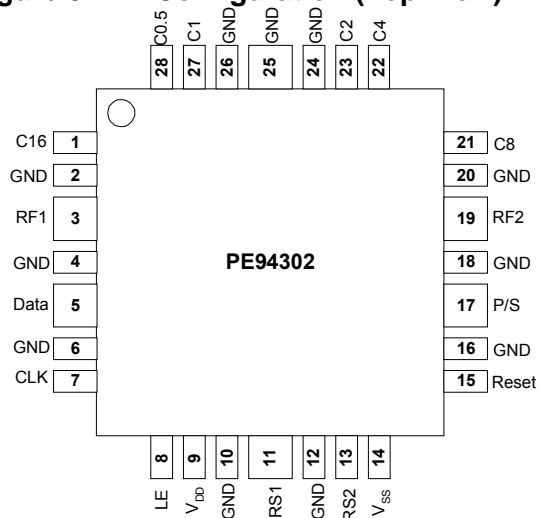


Table 2. Pin Descriptions

Pin No.	Pin Name	Description
1	C16	Attenuation control bit, 16dB
2	GND	Ground connection
3	RF1	RF port (Note 1).
4	GND	Ground connection
5	Data	Serial interface data input
6	GND	Ground connection
7	CLK	Serial interface clock input.
8	LE	Latch Enable input (Note 2).
9	V _{DD}	Power supply pin.
10	GND	Ground connection
11	RS1	Reset Selection (note 3)
12	GND	Ground connection
13	RS2	Reset Selection (Note 3)
14	V _{SS}	Negative supply voltage
15	Reset	Reset (Note 4)
16	GND	Ground connection
17	P/S	Parallel/Serial mode select.
18	GND	Ground connection
19	RF2	RF port (Note 1).
20	GND	Ground connection
21	C8	Attenuation control bit, 8 dB.
22	C4	Attenuation control bit, 4 dB.
23	C2	Attenuation control bit, 2 dB.
24	GND	Ground connection
25	GND	Ground connection
26	GND	Ground connection
27	C1	Attenuation control bit, 1 dB.
28	C0.5	Attenuation control bit, 0.5 dB.
Paddle	GND	Ground connection

Note 1: Both RF ports must be held at 0 V_{DC} or DC blocked with an external series capacitor.

2: Latch Enable (LE) has an internal 100 kΩ resistor to V_{DD}.

3: Must be tied to V_{DD} or GND under normal operation.

4: Must be tied to GND under normal operation

Table 3. Absolute Maximum Ratings

Symbol	Parameter/Conditions	Min	Max	Units
V _{DD}	Power supply voltage	-0.3	4.0	V
V _{SS}	Negative Power supply voltage (-V _{DD})	-4.0	0.3	V
V _I	Voltage on any DC input	-0.3	V _{DD} +0.3	V
T _{ST}	Storage temperature range	-65	150	°C
P _{IN}	Input power (50Ω)		24	dBm
V _{ESD}	ESD voltage (Human Body Model)		500	V

Absolute Maximum Ratings are those values listed in the above table. Exceeding these values may cause permanent device damage. Functional operation should be restricted to the limits in the DC Electrical Specifications table. Exposure to absolute maximum ratings for extended periods may affect device reliability.

Table 4. DC Electrical Specifications

Parameter	Min	Typ	Max	Units
V _{DD} Power Supply Voltage	2.7	3.0	3.3	V
V _{SS} Power Supply Voltage	-3.3	-3.0	-2.7	V
I _{DD} Power Supply Current			100	μA
I _{SS} Power Supply Current	-100			μA
T _{OP} Operating temperature range	-40		85	°C
Digital Input High	0.7xV _{DD}			V
Digital Input Low			0.3xV _{DD}	V
Digital Input Leakage			1	μA

Exposed Solder Pad Connection

The exposed solder pad on the bottom of the package must be grounded for proper device operation.

Electrostatic Discharge (ESD) Precautions

When handling this UltraCMOS™ device, observe the same precautions that you would use with other ESD-sensitive devices. Although this device contains circuitry to protect it from damage due to ESD, precautions should be taken to avoid exceeding the rate specified in Table 3.

Latch-Up Avoidance

Unlike conventional CMOS devices, UltraCMOS™ devices are immune to latch-up.

Switching Frequency

The PE94302 has a maximum 25 kHz switching rate.

Programming Options

Parallel/Serial Selection

Either a parallel or serial interface can be used to control the PE94302. The P/S bit provides this selection, with P/S=LOW selecting the parallel interface and P/S=HIGH selecting the serial interface.

Parallel Mode Interface

The parallel interface consists of six CMOS-compatible control lines that select the desired attenuation state, as shown in Table 5.

The parallel interface timing requirements are defined by Figure 5 (Parallel Interface Timing Diagram), Table 8 (Parallel Interface AC Characteristics), and switching speed (Table 1).

For *latched* parallel programming the Latch Enable (LE) should be held LOW while changing attenuation state control values, then pulse LE HIGH to LOW (per Figure 5) to latch new attenuation state into device.

For *direct* parallel programming, the Latch Enable (LE) should be either pulled high or floated (see Table 2, note 2). Changing attenuation state control values will change device state to new attenuation. Direct Mode is ideal for manual control of the device (using hardwire, switches, or jumpers).

Table 5. Truth Table

P/S	C16	C8	C4	C2	C1	C0.5	Attenuation State
0	0	0	0	0	0	0	Reference Loss
0	0	0	0	0	0	1	0.5 dB
0	0	0	0	0	1	0	1 dB
0	0	0	0	1	0	0	2 dB
0	0	0	1	0	0	0	4 dB
0	0	1	0	0	0	0	8 dB
0	1	0	0	0	0	0	16 dB
0	1	1	1	1	1	1	31.5 dB

Note: Not all 64 possible combinations of C0.5-C16 are shown in table

Serial Interface

The serial interface is a 6-bit serial-in, parallel-out shift register buffered by a transparent latch. It is controlled by three CMOS-compatible signals: Data, Clock, and Latch Enable (LE). The Data and Clock inputs allow data to be serially entered into the shift register, a process that is independent of the state of the LE input.

The LE input controls the latch. When LE is HIGH, the latch is transparent and the contents of the serial shift register control the attenuator. When LE is brought LOW, data in the shift register is latched.

The shift register should be loaded while LE is held LOW to prevent the attenuator value from changing as data is entered. The LE input should then be toggled HIGH and brought LOW again, latching the new data. The timing for this operation is defined by Figure 4 (Serial Interface Timing Diagram) and Table 7 (Serial Interface AC Characteristics).

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Data Sheet Identification

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The product is in a formative or design stage. The data sheet contains design target specifications for product development. Specifications and features may change in any manner without notice.

Preliminary Specification

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